



Vishay Siliconix

N-Channel 20-V (D-S), 175 °C MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	$r_{DS(on)}\left(\Omega\right)$	I _D (A) ^a	Q _g (Typ)		
20	0.0033 at V _{GS} = 10 V	40	30 nC		
	0.0044 at $V_{GS} = 4.5 \text{ V}$	40	30 110		

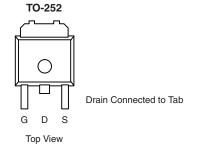
FEATURES

- TrenchFET® Power MOSFET
- 100 % R_g Tested

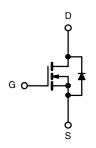


APPLICATIONS

Server







N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS	T _A = 25 °C, unles	s otherwise note	ed		
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	20	V		
Gate-Source Voltage		V _{GS}	± 20		
	T _C = 25 °C		40 ^a		
Continuous Drain Current (T _{.I} = 150 °C)	T _C = 100 °C		40 ^a		
Continuous Diain Current (1) = 150 °C)	T _A = 25 °C	I _D	24.4 ^b		
	T _A = 100 °C		17.2 ^b	A	
Pulsed Drain Current		I _{DM}	100		
Continuous Source Drain Diade Current	T _C = 25 °C		40 ^a		
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S —	2.8 ^b		
Maximum Power Dissipation	T _C = 25 °C		79		
	T _C = 100 °C	ь Г	39.5	w	
	T _A = 25 °C	P _D	3.3 ^b		
	T _A = 100 °C		1.6 ^b		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 175	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^b	Steady State	R_{thJA}	37	45	°C/W	
Maximum Junction-to-Case	Steady State	R _{thJC}	1.5	1.9]	

Notes:

a. Package limited.

b. Surface Mounted on 1" x 1" FR4 board.

SUD40N02-3m3P

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SPECIFICATIONS $T_J = 25 ^{\circ}\text{C}$	Symbol	Test Conditions	Min.	Typ.	Max.	Unit	
Static		1000 00000000		.,,,,			
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$	20			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$			21			
$V_{\text{GS(th)}}$ Temperature Coefficient $\Delta V_{\text{GS(th)}}$ $\Delta V_{\text{GS(th)}}$		- I _D = 250 μA		- 6.9		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1		3	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
<u> </u>		V _{DS} = 20 V, V _{GS} = 0 V			1		
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 20 V, V _{GS} = 0 V, T _J = 100 °C			20	μΑ	
On-State Drain Current ^a		$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	30			Α	
	r _{DS(on)}	V _{GS} = 10 V, I _D = 20 A		0.0027	0.0033	Ω	
Drain-Source On-State Resistance ^a		V _{GS} = 4.5 V, I _D = 20 A		0.0036	0.0044		
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 20 A		100		S	
Dynamic ^b		50 5		1		<u>I</u>	
Input Capacitance	C _{iss}			6520		pF	
Output Capacitance	C _{oss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz		1430			
Reverse Transfer Capacitance	C _{rss}			770			
·	Q _g	$V_{DS} = 10 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 50 \text{ A}$		105	160		
Total Gate Charge				50	75	nC	
Gate-Source Charge		$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 50 \text{ A}$		17			
Gate-Drain Charge	Q _{qd}			14			
Gate Resistance	R _q	f = 1 MHz		1.2	1.9	Ω	
Turn-On Delay Time	t _{d(on)}			40	60		
Rise Time	t _r	$V_{DD} = 10 \text{ V}, R_L = 0.2 \Omega$ $I_D \cong 50 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		30	45		
Turn-Off Delay Time	t _{d(off)}			67	101		
Fall Time	t _f			33	50		
Turn-On Delay Time t _{d(or}				13	20	ns	
Rise Time				7	11		
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 50 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		40	60		
Fall Time	t _f			9	14		
Drain-Source Body Diode Characteris	tics						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			40	A	
Pulse Diode Forward Current ^a	I _{SM}				100		
Body Diode Voltage	V _{SD}	I _S = 20 A		0.81	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			38	57	ns	
Body Diode Reverse Recovery Charge Q _{rr}				34	51	nC	
Reverse Recovery Fall Time	ta	$I_F = 50 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		18		ns	
Reverse Recovery Rise Time	t _b			20			

Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.

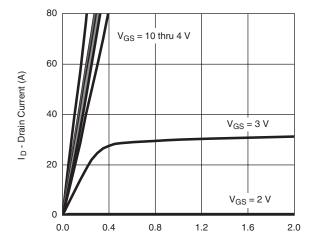
3.0



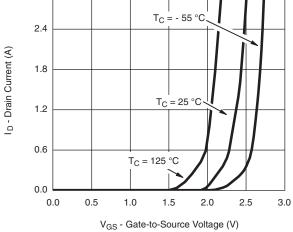


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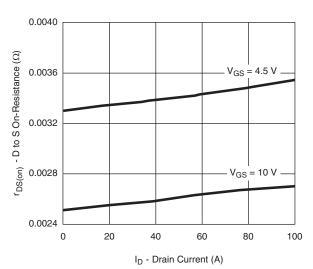
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



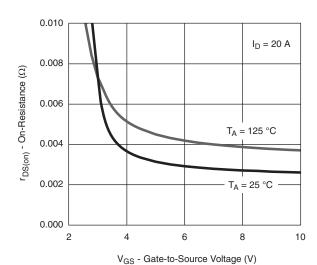
V_{DS} - Drain-to-Source Voltage (V) **Output Characteristics**



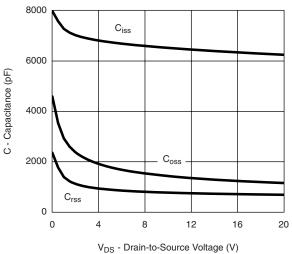
Transfer Characteristics



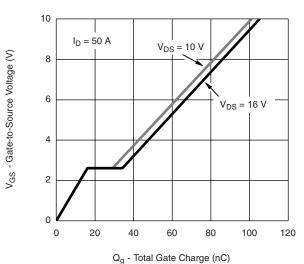
On-Resistance vs. Drain Current



On-Resistance vs. V_{GS} vs. Temperature



Capacitance



Gate Charge

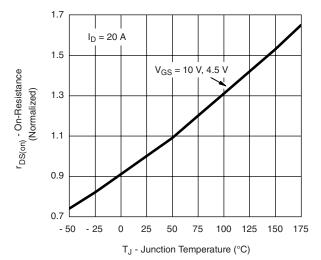
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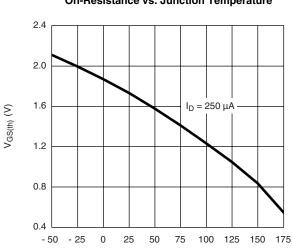
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



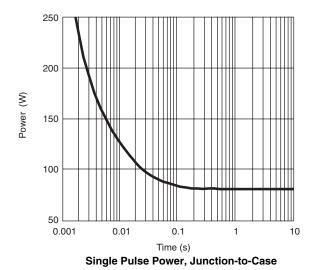
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On-Resistance vs. Junction Temperature

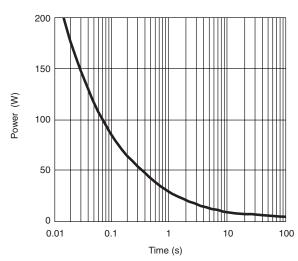


T_J - Temperature (°C) **Threshold Voltage**

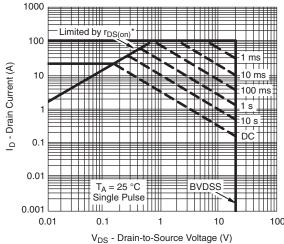


100 Is - Source Current (A) T_J = 150 °C 10 T_{.1} = 25 °C 0.0 0.2 0.6

V_{SD} - Source-to-Drain Voltage (V) Forward Diode Voltage vs. Temperature



Single Pulse Power, Junction-to-Ambient



* V_{GS} > minimum V_{GS} at which $r_{DS(on)}$ is specified

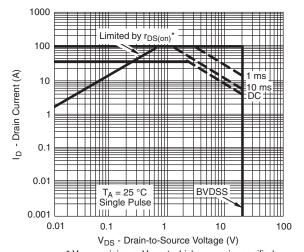
Safe Operating Area, Junction-to-Ambient



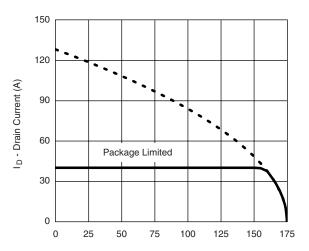


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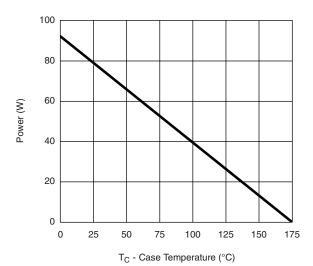
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



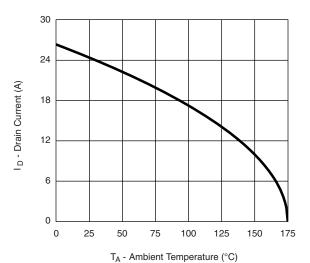
* V_{GS} > minimum V_{GS} at which r_{DS(on)} is specified **Safe Operating Area, Junction-to-Case**



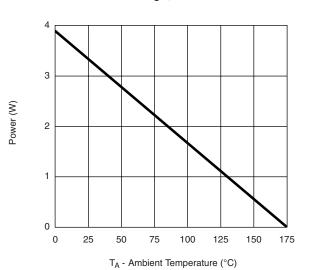
 $\label{eq:TC} T_C \text{ - Case Temperature (°C)}$ Current Derating**, Junction-to-Case



Power Derating**, Junction-to-Case



Current Derating**, Junction-to-Ambient



Power Derating**, Junction-to-Ambient

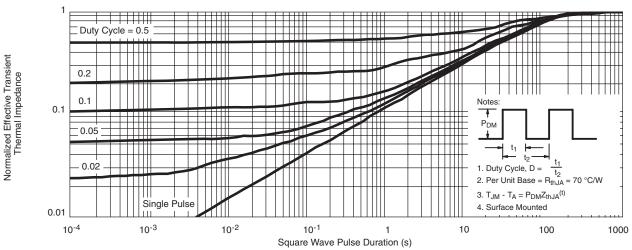
^{**} The power dissipation P_D is based on $T_{J(max)} = 175$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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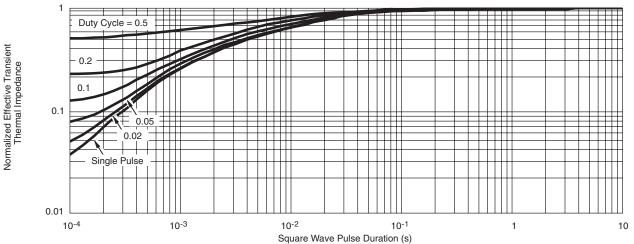
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TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

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